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Application/Control No.	Applicant(s)/Patent under Reexamination	
09/945,116	SHEN ET AL.	
Examiner	Art Unit	
Rehrooz Senfi	2621	

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Class	Subclass	Date	Examiner
348	401 397 398 423 412 413 414 415	4/17/2007	В
=	409 408	"	В
=	407 415	AP E	В
=	401 402	U	В
=	422 405	4	В
=	416 400 417	11	В
382	238 239	v	В
=	173 253 240	"	В
=	251 270 236	7	В
=	232 235	11	В
375	240.16 240.2 <i>J</i>	ı	В
=	240.18 240.15	4	В
= 1	240.12 240.2	4	В
=	240.24 240,21	11	В

INTERFERENCE SEARCHED			
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claim	Text	417-107	B.
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DATE	EXMR
4/17/2007	В
4/17/2007	В
1/24/2007	В
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9/21/2006	В
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